

Notice of References Cited

Application/Control No.

10/709,984

Applicant(s)/Patent Under
Reexamination
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Examiner

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2621

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,754,435	06-2004	Kim, Kwang Su	386/69
	B	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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